

Optimization of Beam Instrumentation for Light Sources

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SYNCHROTRON LIGHT SOURCES

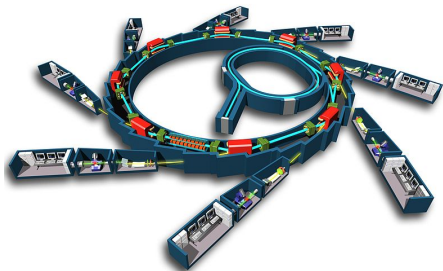
BEAM DIAGNOSTIC @ SLS

SUMMARY

SYNCHROTRON RADIATION

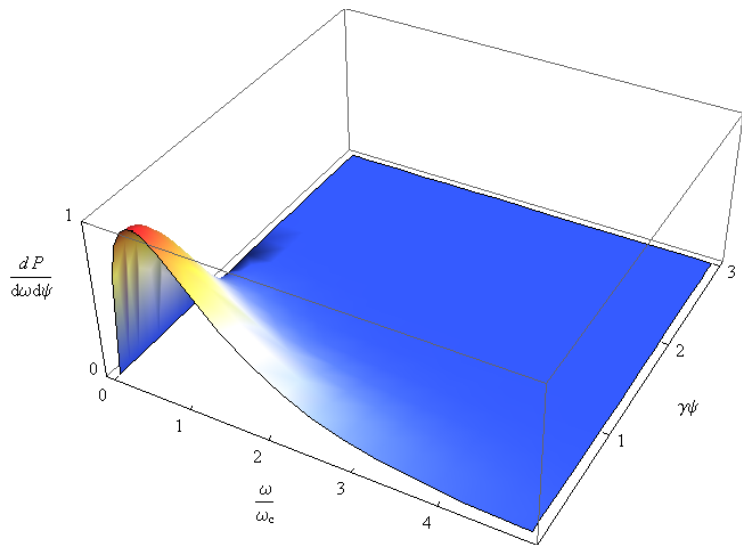
The electromagnetic radiation emitted when a high energetic charged particle is accelerated radially is called *Synchrotron Radiation*

- ▶ High radiation flux
- ▶ High brilliance
- ▶ Wide radiation spectrum
- ▶ Tunability
- ▶ Defined polarization

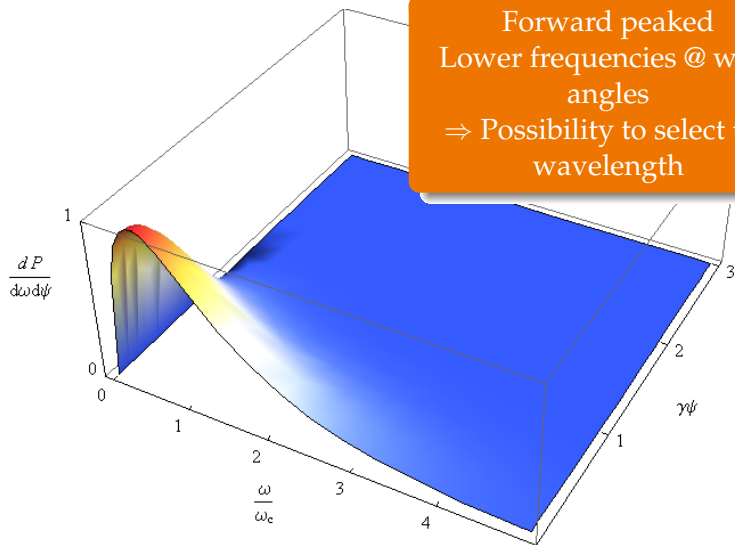




POWER DISTRIBUTION



POWER DISTRIBUTION



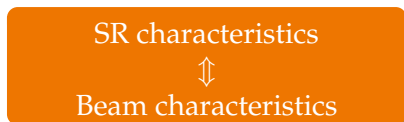
Forward peaked
 Lower frequencies @ wide angles
 ⇒ Possibility to select the wavelength

SYNCHROTRON LIGHT SOURCES

BEAM DIAGNOSTIC @ SLS

SUMMARY

BEAM DIAGNOSTIC USING SR



Advantages

- ▶ Produced “for free”
- ▶ Wide spectrum
- ▶ Real-time
- ▶ Non-invasive

Disadvantages

- ▶ Need of a source
- ▶ Radiation exposure
- ▶ “Only” for light particles
- ▶ Machine design

BEAM DIAGNOSTIC USING SR

SR characteristics



Beam characteristics

Advantages

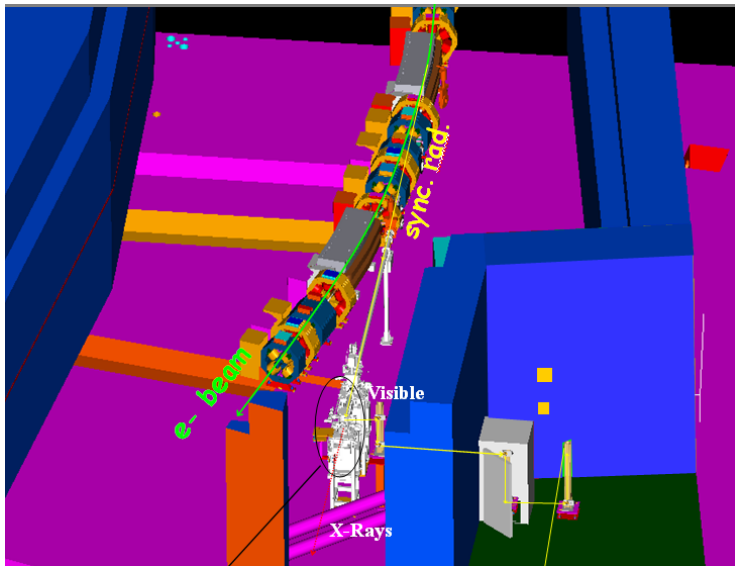
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Disadvantages

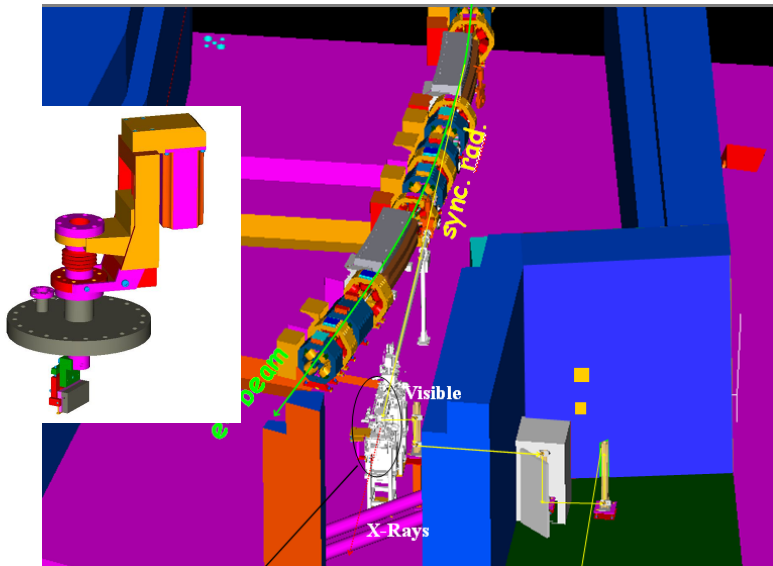
- ▶ Need of a source
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Visible radiation coming from a bending and extracted through a mirror chicane

DIAGNOSTIC BEAMLINE



DIAGNOSTIC BEAMLINE

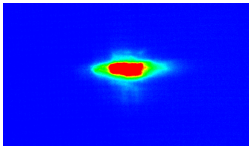


DIAGNOSTIC USING SR

Transverse beam measurements

- ▶ Beam size (Visible)

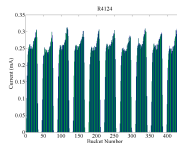
Imaging



Longitudinal beam measurements

- ▶ Filling pattern

Timing

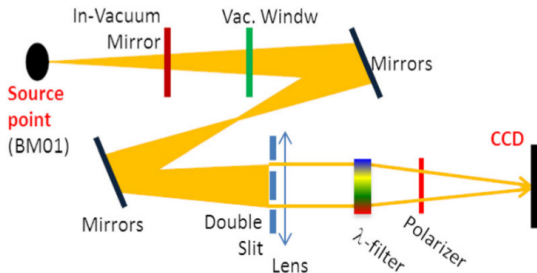


BEAM SIZE-INTERFEROMETRY

Measurement of the first order of spatial coherence of the synchrotron radiation using a double slit interferometer

$$\sigma = \frac{\lambda d_0}{\pi D} \sqrt{\frac{1}{2} \ln \frac{1}{V}}$$

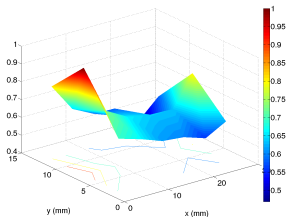
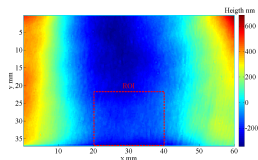
$$V = \frac{I_{Max} - I_{Min}}{I_{Max} + I_{Min}}$$



OPTIMIZATION

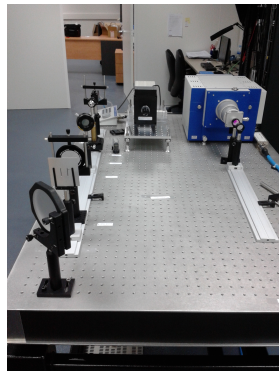
Optics

Use of high quality optical components not to deform the waveform



Acquisition

Use of a Fast Gated Camera to perform Bunch by Bunch transverse size measurements



LONGITUDINAL MEASUREMENTS

The longitudinal structure of a circular accelerator is defined by the beam revolution period and the accelerating RF-frequency

$$h = T \times f_{RF}$$

The machine is divided into h *Buckets*.
Each bucket can be filled with a bunch

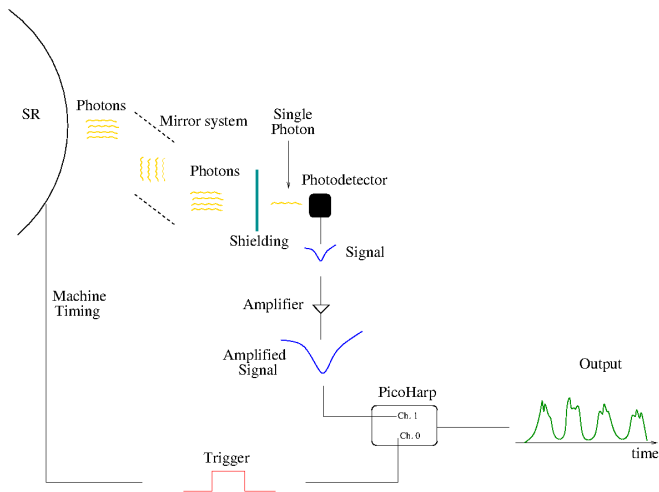


Filling Pattern

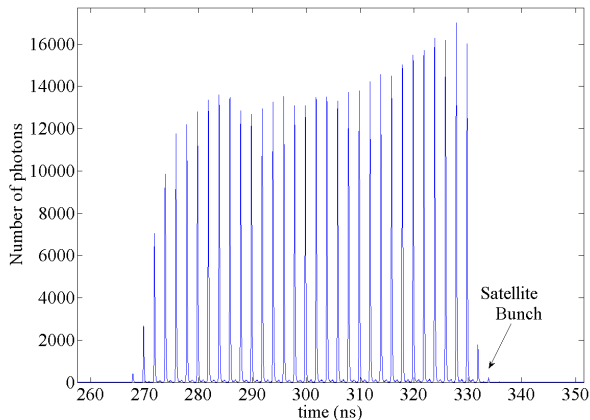
The scheme of distribution of bunches among the machine buckets

FILLING PATTERN-TCSPC

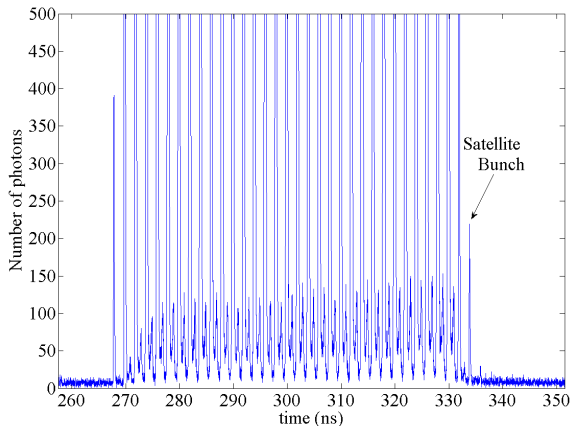
Time Correlated Single Photon Counting



FILLING PATTERN-TCSPC



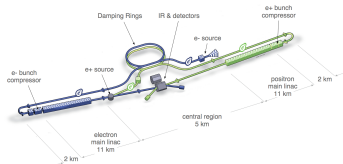
FILLING PATTERN-TCSPC



Dynamic Range better than $10^3 \Rightarrow$ Also bunch purity experiments

NOT ONLY SLS!

Electron Machines/Linear Collider



LHC

- ▶ Bunch Purity with TCSPC
- ▶ Imaging
- ▶ Interferometry

Possibility of using undulators to increase the photon flux

Muon Storage Rings

Need to know the muon energy \Rightarrow Measure the μ g-2 using SR emitted by muon decay electrons

$$\omega_a = a_\mu \gamma \omega_{cic}$$

SUMMARY

- ▶ Synchrotron radiation
 - ▶ Physical characteristics
- ▶ Application in machine diagnostic
- ▶ Transverse beam size
 - ▶ Further optimizations
- ▶ Longitudinal measurements
 - ▶ Further optimizations

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